

<b>Notice of References Cited</b>	Application/Control No. 10/660,722	Applicant(s)/Patent Under Reexamination NISHIDE ET AL.	
	Examiner Carolyn A. Paden	Art Unit 1761	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0198727	10-2003	Koike et al.	426/601
*	B	US-2004/0052920	03-2004	Koike et al.	426/601
*	C	US-5,879,735	03-1999	Cain et al.	426/603
*	D	US-6,448,292	09-2002	Koike et al.	514/558
*	E	US-2003/0054082	03-2003	Koike et al.	426/601
*	F	US-6,139,897	10-2000	Goto et al.	426/601
*	G	US-2004/0265466	12-2004	Takase et al.	426/601
*	H	US-6,844,021	01-2005	Koike et al.	426/611
*	I	US-2005/0054621	03-2005	Gako-Golan et al.	514/171
*	J	US-2005/0123667	06-2005	Sakuma et al.	426/601
*	K	US-7,008,661	03-2006	Koike et al.	426/601
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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